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An efficient non-Lambertian organic light-emitting diode using imprinted submicron-size zinc oxide pillar arrays

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We report phosphorescent organic light-emitting diodes with a substantially improved light outcoupling efficiency and a wider angular distribution through applying a layer of zinc oxide periodic nanopillar arrays by pattern replication in non-wetting templates technique. The devices exhibited the peak emission intensity at an emission angle of 40° compared to 0° for reference device using bare ITO-glass. The best device showed a peak luminance efficiency of 95.5 ± 1.5 cd/A at 0° emission (external quantum efficiency—EQE of 38.5 ± 0.1%, power efficiency of 127 ± 1 lm/W), compared to that of the reference device, which has a peak luminance efficiency of 68.0 ± 1.4 cd/A (EQE of 22.0 ± 0.1%, power efficiency of 72 ± 1 lm/W), © 2013 American Institute of Physics.

Organic light-emitting diodes (OLEDs) have attracted great interest because of their great potential in display and lighting industries. Even though a 100% internal quantum efficiency (IQE) has been realized by using phosphorescent emitters,1 the external quantum efficiency (EQE) encounters a bottleneck, which is due to the low light extraction efficiency. In conventional OLEDs in a planar waveguide-like structure, because of the refractive index difference between organics (n ≈ 1.8) and ITO (1.8), glass substrate (1.5), and air (1.0),2 total internal reflection (TIR) occurs at the organic/ITO-glass substrate and glass-air interfaces. This results in about 50% of internally generated light being trapped in the organic/ITO layers (organic/ITO mode), and about 30% are trapped in the glass substrate (glass mode). Therefore, only around 20% of internally generated photons can be extracted into air.3–5

The low light extraction efficiency of OLEDs leaves much room for improvement. Techniques such as substrate roughening6 and microlens array (MLA)7,8 were applied to the backside of glass substrate to outcouple the glass mode, while techniques like photonic crystals (PCs),9,10 low index gridding,11–13 and corrugation structures14,15 were commonly introduced inside the OLEDs structure to extract light trapped in the organic/ITO mode. Among the above mentioned techniques, PCs attracted much attention because of their capability to control photons in various ways by designing different photonic nanostructures.9,10,16,17 However, most of these techniques involve several steps necessary for fabricating PCs such as chemical vapour deposition (CVD), electron beam (EB) lithography, and reactive ion etching (RIE), etc.,9 which are very time consuming and cost inefficient for industrial production. The pattern replication in non-wetting templates (PRINTs) technique,16,18,19 in contrast, is a simple, cost-effective method to fabricate the PC gratings with high throughput.

In this paper, we proposed and demonstrated nano-meter sized zinc oxide (ZnO) pillars prepared by the PRINT technique at the backside of glass substrate as the light extraction medium for OLEDs. Significant improvement was achieved compared to the reference device using bare ITO-glass. The best device shows a maximum emission intensity level at 40° viewing angle. At 0° viewing angle, it yields a maximum luminous efficacy of 95.5 ± 1.5 cd/A, which corresponds to 40.4% improvement compared to that of the reference device (68.0 ± 1.4 cd/A) measured at 0°. When integrated over all viewing angles, we achieved an EQE of 38.5 ± 0.1% (power efficiency of 127 ± 1 lm/W), corresponding to about 75% enhancement in total light output. Both two-dimensional Lumerical finite difference time domain (FDTD) simulation and numerical fitting using diffraction theory were carried out to verify the experimental results. The improvement is attributed to the combined effects of diffraction grating and higher extraction probability due to the light incident on vertical walls of the ZnO nanopillars. Furthermore, the light extraction efficiency is more sensitive to the variation in filling factor at lower fill factor (FF) value as compared to higher values.

Figure 1(a) briefly illustrates the PRINT technique used to fabricate submicron-size ZnO pillar array. Polydimethylsiloxane (PDMS) mold was first prepared using the patterned silicon master substrate, and then the PDMS mold was pressed on the backside of patterned ITO glass substrate pre-drop-casted with ZnO solgel nanoparticles, holding at constant pressure. The ZnO gel was prepared by stirring the 0.1 M Zn(Ac)2 solution at 60°C for 10 h and then filtered by a filter paper with a

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pore size of 400 nm. Following the application of the mold on ZnO solgel, the substrate was then heated for solvent evaporation. Subsequently, the mold was peeled off, leaving behind the periodical pillar arrays. Finally, the as-prepared substrate was annealed at 250°C for 0.5 h to obtain the ZnO pillars array.

OLEDs were fabricated with the following device structure: ITO/MoO3 (20 nm)/4,4',4''-tris(N-carbazolyl) triphenylamine (TCTA) (60 nm)/4,4'-N,N''-dicarbazole-biphenyl (CBP): fac-tris(2-phenyl-pyridinato-N,C2) iridium (Ir(ppy)3) (5%, 20 nm)/1,3,5-tris(N-phenylbenzimidazole-2-yl)benzene (TPBI) (50 nm)/LiF (1 nm)/Al (100 nm), where MoO3 was used as the hole injection layer (HIL), TCTA as the hole transport layer (HTL), CBP: Ir(ppy)3 as the emissive layer (EML), TPBI as the electron transport layer (ETL), LiF as the electron injection layer (EIL), and Al as the cathode. For the reference device, OLEDs stacks were fabricated on plain glass substrate without using any light outcoupling structure, while the test devices were fabricated on the glass substrate with their backsides pre-coated with ZnO pillar arrays with the pitches of 400 nm, 500 nm, 650 nm, and 800 nm, respectively. A schematic diagram of the device structure with the ZnO pillar array is shown in Figure 1(b). The radii and heights of the ZnO cylindrical pillars were designed to be fixed around 200 nm. While the pitches of the ZnO pillar arrays were measured to be 400 nm, 500 nm, 650 nm, and 800 nm as indicated by the SEM images shown in Figures 2(a)–2(d), respectively.

Figure 3 shows the luminance versus voltage (L–V) and current efficiency versus current density (CE-J) for the reference device and the test devices, while the inset shows their normalized emission spectra. The performance of various devices was measured at 0° viewing angle (perpendicular to the emitting surface). From Figure 3(a), it can be seen that different devices have different luminance behavior, device with 650 nm ZnO pillar pitch exhibits the largest luminance, and its luminance reaches 8442 ± 100 cd/m² when the applied voltage (current density) is 6.43 V (10 mA/cm²). Under the same electrical conditions, device with the ZnO pillar pitch of 400 nm, 500 nm, and 800 nm also exhibits an improved luminance level of 6916 ± 200 cd/m², 7331 ± 128 cd/m², and 6325 ± 75 cd/m², respectively, compared to the reference device that shows a luminance of 6041 ± 16 cd/m². The enhanced performance of tested devices implies higher light extraction efficiency compared to the reference device. The current efficiency also differs significantly for different devices. For example, at 0° viewing angle, device with 650 nm pitch exhibits a maximum efficiency of 95.5 ± 1.5 cd/A. This corresponds to 40.4% improvement as compared to that of the reference device, which shows a maximum current efficiency of 68.0 ± 1.4 cd/A, while devices with 400 nm, 500 nm, and 800 nm pitches show maximum current efficiencies of 77.8 ± 0.6 cd/A, 82.6 ± 3.4 cd/A, 73.7 ± 0.1 cd/A, corresponding to an improvement of 14.4%, 21.5%, and 8.4%, respectively, compared to that of the reference device. The inset depicts the normalized spectra for the reference device and the tested devices. Corresponding to the efficiency improvement levels, we observed that device with 650 nm pitch has the most significantly different spectrum compared to the reference device, while the device with 500 nm pitch shows slightly less significant change in spectrum compared with that of the device.
with 650 nm pitch. Furthermore, both devices with 400 nm and 800 nm pitches show the least deviation from that of the reference device. The significance of change in spectrum follows the trend of efficiency improvement, the difference clearly arises from diffraction of light by the ZnO nanopillars. The deeper reason of the efficiency enhancement will be described with simulation in later paragraphs.

Figure 4(a) shows the normalized angular emission intensity for the reference and tested devices. The reference and devices with 400 nm and 800 nm pitches have similar angular distribution characteristics, where they both show the maximum emission intensity at the low emission angle (close to normal incidence) in a typical Lambertian emission pattern. This implies that the diffraction effect for devices with the pitch of 400 nm and 800 nm is not very significant. The devices with 500 nm and 650 nm pitches, however, show very different angular emission behaviors. For example, the device with 650 nm pitch shows its maximum emission intensity at an observation angle of 40° and its emission intensity decreasing at only higher emission angles. Although the peak intensity of device with 500 nm pitch was detected at 0° viewing angle, compared to reference device, it shows a broader emission at higher angles. The different angular emission behaviors could be explained by the grating effect of the ZnO pillar arrays shown below.

The presence of the periodic ZnO nanopillars enables the extraction of the trapped light into air. Diffraacted light follows:

$$\lambda = p(n \sin \theta_{in} + \sin \theta_{dif}), \quad (1)$$

where $\lambda$ is the emission wavelength, $p$ is the pitch of ZnO pillar array, $n$ is the refractive index of the glass substrate, $\theta_{in}$ is the incident angle, and $\theta_{dif}$ is the diffracted angle. From Eq. (1), if the incidence angle is 0° (inset of Figure 4(d)), the emission intensity of the diffracted light becomes

$$f(\theta) = A \times \left( \cos \left( \frac{\pi p}{\lambda} \times \sin(\theta) \right) \right)^2. \quad (2)$$

Here $A$ represents the amplitude of light extracted by the grating, $p$ is the pitch of ZnO pillar array, $\lambda$ is the wavelength, which is set to the peak wavelength 510 nm in this case, and $\theta$ is the emission angle viewed from air.

Figure 4(b) shows the intensity of the diffracted light emitted from the tested devices with different pitches as a function of the emission angle. These were obtained by subtracting the total angular emission for the corresponding device with that of the control device. The resulted curves were fitted using Eq. (2). The fitted lines show good agreement with the experimental results, especially for devices with 500 nm and 650 nm pitches. The constant $A$ resulted from fitting is 0.05, 0.13, 0.22, and 0.01 for device with 400 nm, 500 nm, 650 nm, and 800 nm pitch, respectively. The much smaller fitting coefficient for device with 400 nm and 800 nm pitches further confirms both devices exhibit weaker diffraction grating effect.

The total number of photons emitted can be calculated by integrating the angular photon density over all angles. Figures 4(c) and 4(d) show the overall EQE and power efficiency versus current density. Here the best device (650 nm pitch) leads to a maximum EQE (power efficiency) of 38.5 ± 0.1% (127 ± 1 lm/W), significantly larger than that of the reference device, which show a maximum EQE (power efficiency) of 22.0 ± 0.1% (72 ± 1 lm/W), while device with 400 nm, 500 nm, and 800 nm pitch exhibits efficiency level of 24.6 ± 0.1% (81.1 ± 0.4 lm/W), 29.9 ± 0.1% (98.5 ± 6.0 lm/W), and 23.3 ± 0.1% (76.8 ± 1.3 lm/W), respectively. The improvement of EQE and power efficiency shown in Figure 4 is slightly different from that of the current efficiency in Figure 3(b), this is expected since current efficiency was measured at specific 0° angle, while both EQE and power efficiency were integrated for all angles to take into account the non-Lambertian emission angular distribution characteristic of the tested devices.

To have better understanding of the physics behind the improvement, a two-dimensional Lumerical FDTD simulation was performed to verify the experiment results. A simulation area of 15 μm x 15 μm is constructed to include multiple period of patterning. Dipole light source is placed in emission layer to replicate the light radiation generated due to electron-hole pair. Physically matched layers are used as boundary condition to surround the simulation area in order to absorb any light radiation impinging on it. ZnO nano-pillar array with 200 nm height and 200 nm radius is placed over the glass surface as shown in Fig. 1. The period of ZnO nano-pillar array is varied and light extraction efficiency (LEE) is measured at 510 nm wavelength in the far-field integrating all extracted light radiation in 1° solid angle. Figures 5(a) and 5(b) show the intensity field distribution with propagation of the reference device and device with ZnO nanopillars, respectively. We can clearly see that light is escaping out of the glass surface due to the presence of ZnO nano-pillar array in comparison to light undergoing TIR from glass-air interface in conventional OLED structure. Figure 5(c) shows the light extraction efficiency versus fill.
factor (FF) for both numerical simulation using Lumerical FDTD and fitting results using Eq. (2) together with experimental data. Our experimental data show similar trend with the simulation results. The simulation deviates slightly from the simplified model using Eq. (2), this implies that pure diffraction grating effect may not be the only reason behind the improvement. Compared to the light that initially undergoes TIR in reference OLED, light in tested devices with incident angle larger than critical angle at ZnO/air interface now has more chance to be extracted if light incident on the ZnO pillars vertical walls, this could be observed clearly from the inset of Figure 5(b), which shows the zoom-in image of the field distribution, the much higher intensity surrounding the ZnO nanopillars indicates more light were outcoupled through the nanopillars. From the plot, we also observed that light extraction ratio is more sensitive to the variation of FF at lower FF value than that in larger region, the FF for cylindrical pillar shaped photonic crystal is calculated by

$$\text{FF} = \frac{\pi r^2}{p^2},$$

where $r$ is the radius of the nanopillar and $p$ is the pitch. The filling factor for ZnO pillars of 400 nm, 500 nm, 650 nm, and 800 nm pitch is 0.8, 0.5, 0.3, and 0.2, respectively. Due to the inverse square proportional relation between the FF and pitch, a small FF change at lower limit equivalent to large variation in pitch. From the experiment results, PC grating resulted in significant drop in efficiency enhancement when the filling factor is too large or too small, which agrees with previous research.17

In conclusion, we have fabricated high efficiency OLEDs with ZnO pillar array at the backside of the glass substrate using PRINT technique. The device with the ZnO pillar array pitch of 650 nm (FF of 0.3) achieved a maximum EQE of 38.5 ± 0.1%, which corresponds to 75.0% enhancement in total light output. Furthermore, the best device reached a maximum current efficiency of 95.5 ± 1.5 cd/A measured at 0° viewing angle, improved by 40.4% compared to the reference measured at the normal incidence. The improvement was attributed to the effective diffraction of light trapped in the glass mode by the ZnO nanopillar arrays.

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